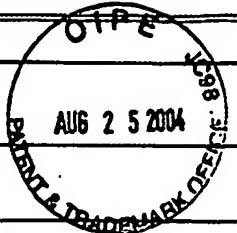


FORM PTO 1449 (<i>modified</i>) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: AUGUST 25, 2004			ATTY DOCKET NO. 2004-0139A	SERIAL NO. 10/771,392			
 APPLICANT Hiroshi IWAI et al.							
FILING DATE February 5, 2004			GROUP 2821				
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.P.	AA	2002/0169010	11/2002	Shoji et al.	481	575	08/2001
T.P.	AB	5,995,052	11/1999	Sadler et al.	343	702	<u> </u>
T.P.	AC	5,561,437	10/1996	Phillips et al.	343	702	<u> </u>
	AD						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
T.P.	AE	2001-156898	06/2001	Japan	<u> </u>	<u> </u>	Abstract
	AF	2002-84355	03/2002	Japan	<u> </u>	<u> </u>	Abstract
	AG	2002-335180	11/2002	Japan	<u> </u>	<u> </u>	Abstract
	AH	2002-299931	10/2002	Japan	<u> </u>	<u> </u>	Abstract
	AI	2002-516503	06/2002	Japan	<u> </u>	<u> </u>	Abstract
	AJ	64-33248	03/1989	Japan	<u> </u>	<u> </u>	X
	AK	8-97622	04/1996	Japan	<u> </u>	<u> </u>	Abstract
	AL	6-216621	08/1994	Japan	<u> </u>	<u> </u>	Partial
	AM	9-64778	03/1997	Japan	<u> </u>	<u> </u>	Partial
✓	AN	10-84406	03/1998	Japan	<u> </u>	<u> </u>	Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER	<i>T.Ho PHAN</i>		DATE CONSIDERED	<i>6/8/05</i>			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of							
FORM PTO 1449 (modified)		MAY 25 2004	ATTY DOCKET NO. 004_0139A		SERIAL NO. 10/771,392		
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICANT Hiroshi IWAI et al.					
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		FILING DATE February 5, 2004			GROUP 2821		
Date Submitted to PTO: May 25, 2004							
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TP	AA	5,903,821	5/1999	Ishizuka	455	83	
	AB	5,649,306	7/1997	Vannatta et al.	455	575	
	AC	4,992,799	2/1991	Garay	343	702	
	AD	6,307,520	10/2001	Liu	343	767	
	AE	6,340,952	1/2002	Tsai et al.	343	741	
↓	AF	6,272,356	8/2001	Dolman et al.	455	550	
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	AH						
	AI						
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
TP	AJ	99/04500	1/1999	WO			
	AK						
	AL						
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER	T+10 PTI AW			DATE CONSIDERED	6/18/05		

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